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**Guidance for the  
Development and  
Implementation of a  
Foreign Object Debris (FOD)  
Control Plan**

*A White Paper Report Developed by IPC*



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- Minimize time to market
- Contain simple (simplified) language
- Just include spec information
- Focus on end product performance
- Include a feedback system on use and problems for future improvement

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- Increase time-to-market
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- Increase cycle time
- Tell you how to make something
- Contain anything that cannot be defended with data

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IPC-WP-116A

# Guidance for the Development and Implementation of a Foreign Object Debris (FOD) Control Plan

Developed by the Wire Harness Design Task Group (7-31k)  
of the Product Assurance Committee (7-30) of IPC

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Users of this publication are encouraged to participate in the  
development of future revisions.

Contact:

IPC  
3000 Lakeside Drive, Suite 309S  
Bannockburn, Illinois  
60015-1219  
Tel 847 615.7100  
Fax 847 615.7105

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### Product Assurance Committee

#### Chair

Robert W. Cooke  
NASA Johnson Space Center

#### Vice-Chair

Debbie Wade  
Advanced Rework Technology

### Wire Harness Design Task Group

#### Chair

Robert W. Cooke  
NASA Johnson Space Center

#### Vice-Chair

Sean Keating  
Amphenol Ltd (UK)

### Technical Liaison of the IPC Board of Directors

#### Bob Neves

Microtek (Changzhou) Laboratories

### Members of Wire Harness Design Task Group

Dominik Alder  
Lockheed Martin Corporation

Anisha Ankush  
ATRON Group LLC

Michael Baker

Vincent Barone  
Panduit Corporation

Geza Batiz  
Toro Co.

Cathy Becker  
JC Manufacturing

James Blanche  
NASA Marshall Space Flight Center

Gerald Bogert  
Bechtel Plant Machinery, Inc.

Alvin Boutte  
NASA Goddard Space Flight Center

Bud Bowen  
Winchester Interconnect

Lance Brack  
Raytheon Missile Systems

Thomas Carle  
Ball Aerospace &  
Technologies Corp.

Zhiman Chen  
Zhuzhou CRRC Times  
Electric Co., LTD.

Thomas Cleere

Robert Cooke  
NASA Johnson Space Center

Stephen Cooke  
Electrical Components International

Miguel Dominguez  
Continental Temic SA de CV

Bill Downton  
Cirris Systems Corporation

Caroline Ehlinger  
Collins Aerospace

Chris Fitzgerald  
NASA Goddard Space Flight Center

Robert Fornefeld  
STI Electronics, Inc.

Daniel Foster  
Missile Defense Agency (MDA)

B.J. Franco  
Honeywell Aerospace

Mahendra Gandhi  
Northrop Grumman Space Systems

Matt Garrett  
Microsemi

Constantino Gonzalez  
ACME Training & Consulting

William Graver  
NTS - Baltimore

Dave Harrell  
Viasat Inc.

Eric Harenburg  
Boeing Company

Rick Hawthorne  
Technical Training Center

Gaston Hidalgo  
Toyota Motor North America

David Hillman  
Collins Aerospace

Shelley Holt  
L3Harris Communications

Ife Hsu  
Intel Corporation

Paula Jackson  
Raytheon UK

Kathy Johnston

Lawrence Joy

Joseph Kane  
BAE Systems

Sean Keating  
Amphenol Ltd (UK)

Jason Keeping  
Celestica International L.P.

Russell Kido  
Practical Components Inc.

Rebekah Kovarik  
Lockheed Martin

Vijay Kumar  
Lockheed Martin Missiles &  
Fire Control

---

Leo Lambert EPTAC Corporation	Sue Powers-Hartman Killdeer Mountain Manufacturing, Inc.	Stephen Tisdale Tisdale Environmental Consulting LLC
Theodore Laser L3Harris Communications	Ray Prasad Ray Prasad Consultancy Group	Jonathon Vermillion Ball Aerospace & Technologies Corp.
Evan Levy	Erik Quam Uson LP	Daniel Versluis HYTEK
John Mastorides Honeywell Aerospace	Edward Rios Motorola Solutions	Debie Vorwald Collins Aerospace
Garry McGuire NASA Marshall Space Flight Center	Richard Rumas Honeywell Canada	Debbie Wade Advanced Rework Technology
Randy McNutt Northrop Grumman Aerospace Systems	Tammy Sargent Collins Aerospace	Schuyler Williams Lockheed Martin Missiles & Fire Control
Roger Miedico Raytheon Company	Martin Scionti Raytheon Vision Systems	Alan Young Jet Propulsion Laboratory
Brett Miller USA Harness, Inc.	Darrell Sensing BAE Systems	Style Yuan Winchester Electronics (Suzhou) Co., Ltd.
George Millman Raytheon Missile Systems	Jose Servin Olivares Vitesco Technologies	Jack Zhu Veoneer China CO., LTD
Fernando Moreno Cesar-Scott, Inc.	Gilbert Shelby Raytheon Systems Company	Yaakov Zissman Elta Systems Ltd.
Mark Northrup Raytheon Missile Systems	Kim Souva Kearfott Corporation	Paul Zutter U.S. Army Aviation & Missile Command
Agnieszka Ozarowski BAE Systems	Toshiyasu Takei Japan Unix Co., Ltd.	
Bob Potysman ATRON Group LLC	Bob Teegarden Honeywell International - Torrance	

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# Guidance for the Development and Implementation of a Foreign Object Debris (FOD) Control Plan

## TECHNICAL BACKGROUND

Most Foreign Object Damage/Foreign Object Debris (FOD) issues can be attributed to poor housekeeping, facilities deterioration, improper maintenance, careless assembly, or inadequate operational practices. An effective FOD Prevention Program (Control Plan) identifies potential problems, corrects negative factors, promotes awareness, provides for effective employee training, and uses “lessons learned” for continual improvement. The objective of any FOD Prevention Program should always be zero FOD, to provide visibility to problem areas and trends, provide management and workers with inspection results, incident/mishap reports, and feedback of progress.

## 1 GENERAL REQUIREMENTS

**1.1 Scope** This document introduces design concepts, attributes, and recommendations for the control and mitigation of performance and reliability risks associated with the introduction of Foreign Object Debris (FOD) in electrical and electronic (E/E) assemblies, including optical and metallic cable and wiring harness assemblies, and elements thereof.

**1.2 Purpose** The intent of this document is to provide guidance and a template for the development and implementation of a Foreign Object Debris (FOD) Control Plan.

For purposes of this document:

- The Designer is the design agent for the User.
- The User is the individual, organization, company, contractually designated authority, or agency responsible for the procurement or design of electrical / electronic / electromechanical (EEE) hardware, and having the authority to define the class of equipment and any variation or restrictions to the requirements of this document (e.g., the originator/custodian of the contract detailing these requirements). The User is the Design Authority.
- The Supplier is the individual, organization or company that provides the Manufacturer (assembler) components (electrical, electronic, electromechanical, mechanical, printed boards, etc.) and/or materials (solder, flux, cleaning agents, etc.).
- The Manufacturer is considered the entity that provides a service or product to the User.

**1.3 Applicability** This document is targeted for control of Foreign Object Debris (FOD) in areas where both critical and complex work is performed, and to operations involved with designing, developing, manufacturing, assembling, testing, operating, repairing, modifying, refurbishing, and maintaining Class 3 (or higher) hardware to the User specified cleanliness level.

- a. The design concepts, guidelines, and procedures presented in this document are for guidance ONLY, and **are not** requirements. As such, the use of the words “**must**,” “**should**” and “**shall**” (and derivations thereof) have no special meaning in this document, and they **do not** indicate a binding criterion.
- b. This document **is not** binding, unless separately and specifically included by the applicable contract, approved drawing(s), or purchase order.

**1.4 Commercial Off-The-Shelf (COTS)** This document **does not** apply to Commercial-Off-The-Shelf (COTS) or catalog items (e.g., components, assemblies, subassemblies and/or hardware). Designers considering the use of COTS hardware for applications described above **are** responsible for identifying and managing risks associated with hardware built without a control plan to control and/or reduce the introduction of Foreign Object Debris (FOD) in electrical and electronic (E/E) assemblies, including optical and metallic cable and wiring harness assemblies, and elements thereof.

**1.5 Existing or Previously Approved Designs** The implementation of a Foreign Object Debris (FOD) Control Plan **should not** constitute the sole cause for the redesign of previously approved designs. When drawings for existing or previously approved designs undergo revision, they **should** be reviewed and changes made that allow for compliance with the requirements of this document.



Figure 1-1 Foreign Object Debris (FOD) Logo